



# **Dual SPDT Analog Switch**

#### **DESCRIPTION**

The DG9236 is a CMOS, dual SPDT analog switch designed to operate from V+ = 2.7 V to V+ = 16 V max. operating, single supply. All control logic inputs have a guaranteed 1.8 V logic high threshold when operation from a + 16 V power supply. This makes the DG9236 ideally suited to interface directly with low voltage micro-processor control signals.

Processed with high density CMOS technology, the DG9236 while providing ultra low parasitic capacitance of 2 pF for CS<sub>(OFF)</sub> and 8.4 pF for CD<sub>(ON)</sub>. Other performance features are: 3 dB bandwidth, 800 MHz, - 70 dB crosstalk and 62 dB off isolation at 10 MHz frequency.

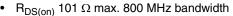
Key applications for the DG9236 are logic level translation, pulse generator, and high speed or low noise signal switching in precision instrumentations and portable device designs.

The operation temperature range is specified from - 40 °C to + 85 °C. The DG9236 is available in space saving 1.4 mm x 1.8 mm miniQFN10 package.

As a committed partner to the community and the environment, Vishay Siliconix manufactures this product with lead (Pb)-free device termination. The miniQFN-10 package has a nickel-palladium-gold device termination and is represented by the lead (Pb)-free "-E4" suffix to the ordering part number. The nickel-palladium-gold device terminations meet all JEDEC standards for reflow and MSL rating.

#### **FEATURES**

- Leakage current < 0.5 nA max. at 85 °C
- Low switch capacitance (C<sub>soff</sub>, 2 pF typ.)



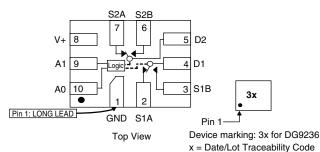
- Fully specified with single supply operation at 16 V COMPLIANT
- Low voltage, 1.8 V CMOS/TTL compatible
- Excellent isolation and crosstalk performance (tvp. > 60 dB at 10 MHz)
- Fully specified from 40 °C to 85 °C
- Latch-up current 300 mA per JESD78
- Lead (Pb)-free low profile miniQFN-10 (1.4 mm x 1.8 mm x 0.55 mm)
- Compliant to RoHS Directive 2002/95/EC

### **APPLICATIONS**

- High-end data acquisition
- Medical instruments
- Precision instruments
- High speed communications applications
- Automated test equipment
- Sample and hold applications

#### **FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION**

### DG9236 miniQFN - 10L



TRUTH TABLE								
Selected Input		On Switches						
A1	A0	DG9236						
Х	0	D1 to S1A						
X	1	D1 to S1B						
0	X	D2 to S2A						
1	X	D2 to S2B						

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ORDERING INFORMATION							
Temp. Range	Package	Part Number					
- 40 °C to 85 °C	10 pin miniQFN	DG9236DN-T1-E4					

#### Notes:

• - 40 °C to 85 °C datasheet limits apply.

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)							
Parameter		Limit	Unit				
V+ to GND		18	V				
Digital Inputs <sup>a</sup> , V <sub>S</sub> , V <sub>D</sub>		(V+) + 0.3 or 30 mA, whichever occurs first	V				
Continuous Current (Any Terminal)		30	A				
Peak Current, S or D (Pulsed 1 ms, 10 %	Duty Cycle)	100	mA				
Storage Temperature		- 65 to 150	°C				
Power Dissipation (Package) <sup>b</sup>	10 pin miniQFN <sup>c, d</sup>	208	mW				
Thermal Resistance (Package) <sup>b</sup>	10 pin miniQFN	357	°C/W				

#### Notes:

- a. Signals on SX, DX, or AX exceeding V+ or GND will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads welded or soldered to PC board.
- c. Derate 2.6 mW/°C above 70 °C.
- d. Manual soldering with iron is not recommended for leadless components. The miniQFN-10 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper lip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

SPECIFICATIONS (for 16 V Supply)								
		Test Conditions			- 40 °C to 85 °C			
Parameter	Symbol	Unless Otherwise Specified	Temp.b	Typ. <sup>c</sup>	Min.d	Max.d	Unit	
Analog Switch	Syllibol	$V+ = 16 \text{ V}, V_{A0, A1} = 1.8 \text{ V}, 0.5 \text{ V}^a$	remp.	тур.	IVIIII.	IVIAX.	Offic	
Analog Signal Range <sup>e</sup>	V <sub>ANALOG</sub>		Full			16	V	
		lo − 1 mA	Room	101		145	V	
On-Resistance	R <sub>DS(on)</sub>	$I_S = 1 \text{ mA},$ $V_D = 0.7 \text{ V}, 2.6 \text{ V}, 8 \text{ V}, 11 \text{ V}, 15.3 \text{ V}$	Full	101		160		
On-Resistance Match	ΔR <sub>ON</sub>	I <sub>S</sub> = 1 mA, V <sub>D</sub> = 0.7 V, 2.6 V, 8 V, 11 V, 15.3 V	Room Full	2		14 15	Ω	
On-Resistance Flatness	R <sub>FLATNESS</sub>	$I_S = 1 \text{ mA},$ $V_D = 0.7 \text{ V}, 2.6 \text{ V}, 8 \text{ V}, 11 \text{ V}, 15.3 \text{ V}$	Room Full	38		55 60		
Switch Off	I <sub>S(off)</sub>	V+ = 16 V,	Room Full	± 0.01	- 1 - 2	1 2		
Leakage Current	I <sub>D(off)</sub>	V <sub>D</sub> = 1 V/15 V, V <sub>S</sub> = 15 V/1 V	Room Full	± 0.01	- 1 - 2	1 2	nA	
Channel On Leakage Current	I <sub>D(on)</sub>	V+ = 16 V, V <sub>D</sub> = V <sub>S</sub> 1 V/15 V	Room Full	± 0.01	- 1 - 2	1 2		
Digital Control								
Input Current, V <sub>IN</sub> Low	I <sub>IL</sub>	V <sub>AX</sub> = 0.5 V	Full	0.005	- 0.1	0.1		
Input Current, V <sub>IN</sub> High	I <sub>IH</sub>	V <sub>AX</sub> = 1.8 V	Full	0.005	- 0.1	0.1	μΑ	
Input Capacitance <sup>e</sup>	C <sub>IN</sub>	f = 1 MHz	Room	3			pF	
Dynamic Characteristics								
Turn-On Time	t <sub>ON</sub>		Room Full	30		70 80		
Turn-Off Time	t <sub>OFF</sub>	$R_L = 300 \Omega$ , $C_L = 35 pF$ see figure 1, 2	Room Full	17		55 65	ns	
Break-Before-Make	t <sub>BBM</sub>		Room Full	19 25	1 1			
Charge Injection <sup>e</sup>	Q <sub>INJ</sub>	$V_g = 0 \text{ V}, R_g = 0 \Omega, C_L = 1 \text{ nF}$	Room	6			рC	
Off Isolation <sup>e</sup>	OIRR	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 10 MHz$	Room	- 62			dB	
Bandwidth <sup>e</sup>	BW	$R_L = 50 \Omega$	Room	800			MHz	
Channel-to-Channel Crosstalk <sup>e</sup>	X <sub>TALK</sub>	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 10 MHz$	Room	- 70			dB	



SPECIFICATIONS (for 16 V Supply)									
		Test Conditions			- 40 °C	to 85 °C			
Parameter	Symbol	Unless Otherwise Specified $V+ = 16 \text{ V}, V_{A0, A1} = 1.8 \text{ V}, 0.5 \text{ V}^a$	Temp.b	Typ. <sup>c</sup>	Min. <sup>d</sup>	Max. <sup>d</sup>	Unit		
Dynamic Characteristics	Dynamic Characteristics								
Source Off Capacitance <sup>e</sup>	C <sub>S(off)</sub>	f = 1 MHz	Room	2			nE.		
Channel On Capacitance <sup>e</sup>	C <sub>D(on)</sub>		Room	8.4			pF		
Total Harmonic Distortion <sup>e</sup>	THD	Signal = 1 $V_{RMS}$ , 20 Hz to 20 kHz, $R_L = 600 \Omega$	Room	0.18			%		
Power Supplies									
Power Supply Current	I+	V <sub>IN</sub> = 0 V, or V+	Room Full	0.013 0.022		0.5 1.0			
Ground Current	I <sub>GND</sub>	VIN = 0 V, OI V+	Room Full	0.01 0.021	- 0.5 - 1.0		μΑ		

SPECIFICATIONS (for 5 V Supply)							
		Test Conditions			- 40 °C	to 85 °C	
Parameter	Symbol	Unless Otherwise Specified $V+ = 5 \text{ V}, V_{A0, A1} = 1.4 \text{ V}, 0.5 \text{ V}^a$	Temp.b	Typ. <sup>c</sup>	Min. <sup>d</sup>	Max. <sup>d</sup>	Unit
Analog Switch							
Analog Signal Range <sup>e</sup>	V <sub>ANALOG</sub>		Full			5	V
On-Resistance	R <sub>DS(on)</sub>	$I_S = 1 \text{ mA}, V_D = 0 \text{ V}, 3 \text{ V}, 3.5 \text{ V}$	Room Full	301		365 380	Ω
On-Resistance Match	$\Delta R_{ON}$	$I_S = 1 \text{ mA}, V_D = 0 \text{ V}, 3 \text{ V}, 3.5 \text{ V}$	Room Full	3		14 15	52
Switch Off	I <sub>S(off)</sub>	V+ = 5.5 V,	Room Full	± 0.01	- 1 - 1.2	1 1.2	
Leakage Current	I <sub>D(off)</sub>	V <sub>D</sub> = 1 V/4.5 V, V <sub>S</sub> = 4.5 V/1 V	Room Full	± 0.01	- 1 - 1.2	1 1.2	nA
Channel On Leakage Current	I <sub>D(on)</sub>	$V+ = 5.5 \text{ V}, V_S = V_D = 1 \text{ V}/4.5 \text{ V}$	Room Full	± 0.01	- 1 - 1.2	1 1.2	
Digital Control							
Input Current, V <sub>IN</sub> Low	ΙL	V <sub>AX</sub> = 0.5 V	Full	0.005	- 0.1	0.1	
Input Current, V <sub>IN</sub> High	I <sub>H</sub>	V <sub>AX</sub> = 1.4 V	Full	0.005	- 0.1	0.1	μΑ
Input Capacitance	C <sub>IN</sub>	f = 1 MHz	Room	3			pF
Dynamic Characteristics							
Turn-On Time	t <sub>ON</sub>		Room Full	70		100 110	
Turn-Off Time	t <sub>OFF</sub>	$R_L = 300 \Omega$ , $C_L = 35 pF$ see figure 1, 2	Room Full	17		70 80	ns
Break-Before-Make-Time	t <sub>BMM</sub>		Room Full	42	5 1		
Charge Injection <sup>e</sup>	Q <sub>INJ</sub>	$C_L = 1 \text{ nF, } R_{GEN} = 0 \Omega, V_{GEN} = 0 \text{ V}$	Full	2			рC
Off-Isolation <sup>e</sup>	OIRR	f = 10 MHz	Room	- 62			dB
Crosstalk <sup>e</sup>	X <sub>TALK</sub>	$f = 10 \text{ MHz}, R_L = 50 \Omega, C_L = 5 \text{ pF}$	Room	- 70			uБ
Bandwidth <sup>e</sup>	BW	$R_L = 50 \Omega$	Room	570			MHz
Total Harmonic Distortion <sup>e</sup>	THD	Signal = 1 $V_{RMS}$ , 20 Hz to 20 kHz, $R_L = 600 \Omega$	Room	2.4			%
Source Off Capacitance <sup>e</sup>	C <sub>S(off)</sub>	f = 1 MHz	Poom	2.1			nE
Channel On Capacitance <sup>e</sup>	C <sub>D(on)</sub>	I = I IVITIZ	Room	8.1			pF
Power Supplies							
Power Supply Current	l+	V <sub>IN</sub> = 0 V, or V+	Room Full	0.001		0.5 1	μА
Ground Current	I <sub>GND</sub>	ν <sub>IN</sub> = υ ν, οι ν+	Room Full	- 0.001	- 0.5 - 1		μΑ



SPECIFICATIONS (for 3 V Supply)								
		Test Conditions			- 40 °C to	o + 85 °C		
Parameter	Symbol	Unless Otherwise Specified $V+=3 V$ , $V_{A0, A1}=1.4 V$ , $0.5 V^a$	Temp.b	Typ. <sup>c</sup>	Min. <sup>d</sup>	Max. <sup>d</sup>	Unit	
Analog Switch								
Analog Signal Range <sup>e</sup>	V <sub>ANALOG</sub>		Full			3	V	
On-Resistance	R <sub>DS(ON)</sub>	$I_S = 1 \text{ mA}, V_D = + 1.5 \text{ V}$	Room Full	732		795 810	Ω	
On-Resistance Match	$\Delta R_{ON}$	$I_S = 1 \text{ mA}, V_D = + 1.5 \text{ V}$	Room Full	5		16 17	22	
Switch Off Leakage Current	I <sub>S(off)</sub>	V+ = 3.3 V, V- = 0 V	Room Full	± 0.01	- 1 - 1.2	1 1.2		
(for 16 pin miniQFN)	I <sub>D(off)</sub>	$V_D = 1 \text{ V/3 V}, V_S = 3 \text{ V/1 V}$	Room Full	± 0.01	- 1 - 1.2	1 1.2	nA	
Channel On Leakage Current (for 16 pin miniQFN)	I <sub>D(on)</sub>	$V_{+} = 3.3 \text{ V}, V_{-} = 0 \text{ V},$ $V_{S} = V_{D} = 1 \text{ V/3 V}$	Room Full	± 0.01	- 1 - 1.2	1 1.2		
Digital Control								
Input Current, V <sub>IN</sub> Low	ΙL	V <sub>AX</sub> = 0.5 V	Full	0.005	- 0.1	0.1		
Input Current, V <sub>IN</sub> High	I <sub>H</sub>	$V_{AX} = 1.4 \text{ V}$	Full	0.005	- 0.1	0.1	μΑ	
Input Capacitance	C <sub>IN</sub>	f = 1 MHz	Room	3.1			pF	
Dynamic Characteristics								
Enable Turn-On Time	t <sub>ON</sub>		Room Full	30		150 170		
Enable Turn-Off Time	t <sub>OFF</sub>	$R_L = 300 \Omega$ , $C_L = 35 pF$ see figure 1, 2	Room Full	20		110 120	ns	
Break-Before-Make-Time	t <sub>BMM</sub>		Room Full	19 25	5 1	not limit		
Charge Injection <sup>e</sup>	Q <sub>INJ</sub>	$C_L = 1 \text{ nF, } R_{GEN} = 0 \Omega, V_{GEN} = 0 V$	Full	1			рC	
Off-Isolation <sup>e</sup>	OIRR	f = 10 MHz, $R_L$ = 50 Ω, $C_L$ = 5 pF	Room	- 63			dB	
Crosstalk <sup>e</sup>	X <sub>TALK</sub>	$1 = 10 \text{ MHz}, \text{ H}_{L} = 30 \text{ L}_{2}, \text{ G}_{L} = 3 \text{ pr}$	Room	- 70			] ub	
Bandwidth <sup>e</sup>	BW	$R_L = 50 \Omega$	Room	183			MHz	
Total Harmonic Distortion <sup>e</sup>	THD	Signal = 1 $V_{RMS}$ , 20 Hz to 20 kHz, $R_L = 600 \Omega$	Room	5.5			%	
Source Off Capacitance <sup>e</sup>	C <sub>S(off)</sub>	£ 4 MI I-	Doom	2.1			,,r	
Channel On Capacitance <sup>e</sup>	C <sub>D(on)</sub>	f = 1 MHz	Room	8.3			pF	
Power Supplies	,							
Power Supply Current	l+	V <sub>IN</sub> = 0 V, or V+	Room Full	0.001		0.5 1	μ. Λ	
Ground Current	I <sub>GND</sub>	v <sub>IN</sub> = 0 v, or v+	Room Full	- 0.001	- 0.5 - 1		μΑ	

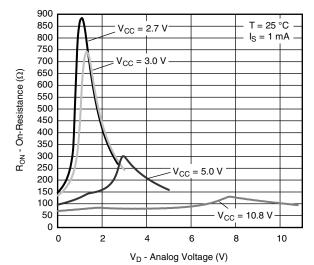
#### Notes:

- a.  $V_{IN}$  = input voltage to perform proper function.
- b. Room = 25 °C, Full = as determined by the operating temperature.
- c. Typical value are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this datasheet.
- e. Guaranteed by design, not subject to production test.

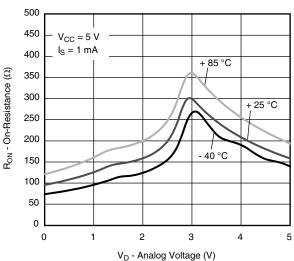
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



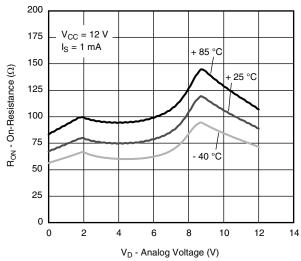
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



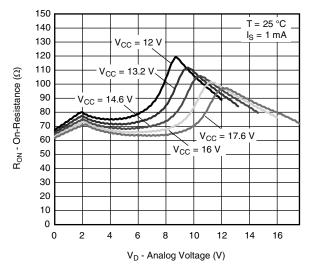
R<sub>ON</sub> vs. V<sub>D</sub> and Single Supply Voltage



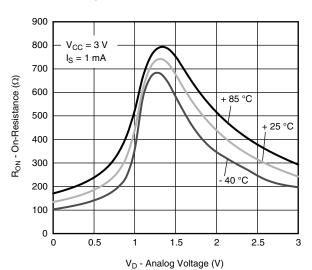
**R<sub>ON</sub> vs. Analog Voltage and Temperature** 



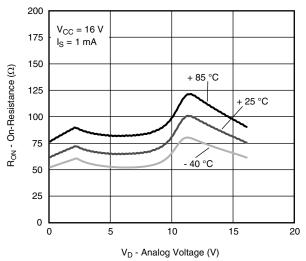
R<sub>ON</sub> vs. Analog Voltage and Temperature



R<sub>ON</sub> vs. V<sub>D</sub> and Single Supply Voltage

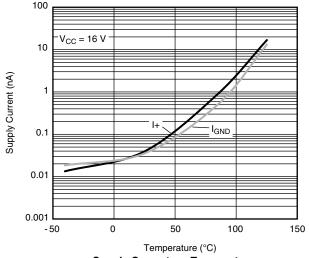


R<sub>ON</sub> vs. Analog Voltage and Temperature

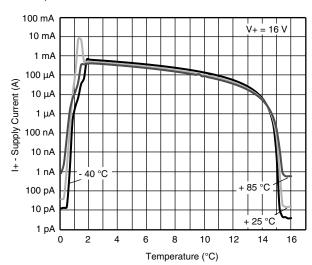


R<sub>ON</sub> vs. Analog Voltage and Temperature

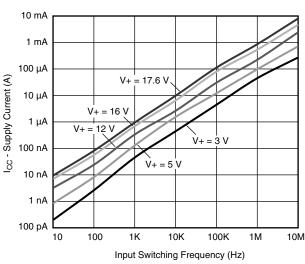
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



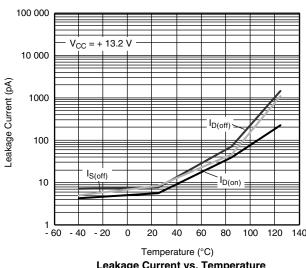
Supply Current vs. Temperature



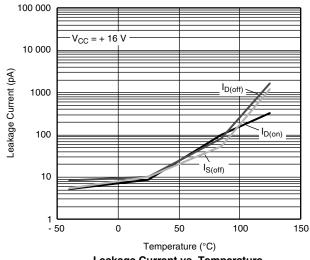
Supply Current vs.  $V_{\text{IN}}$  and Temperature



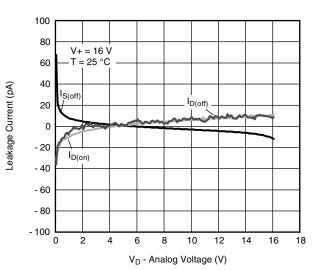
Supply Current vs. Input Switching Frequency



Leakage Current vs. Temperature



Leakage Current vs. Temperature

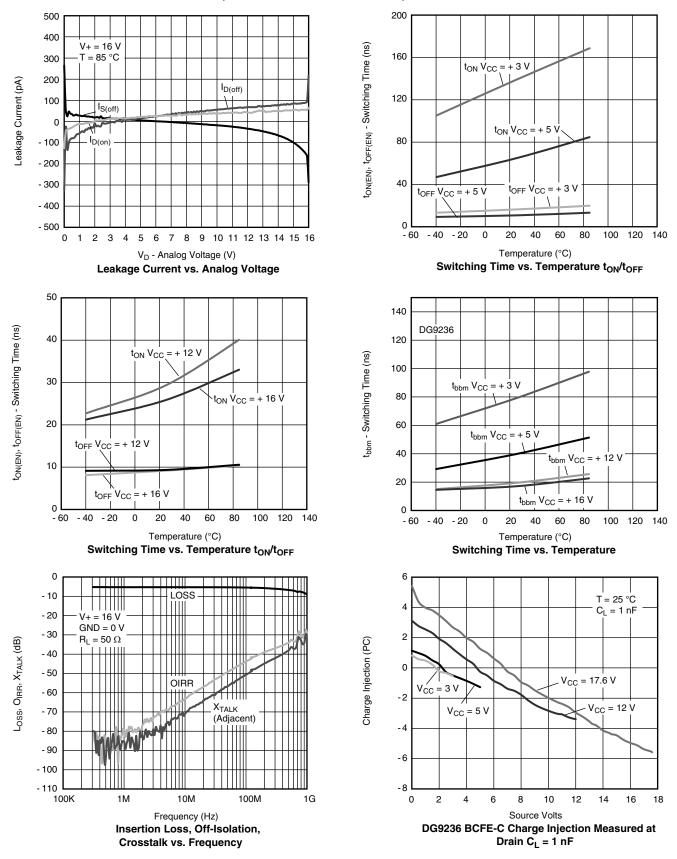


Leakage Current vs. Analog Voltage

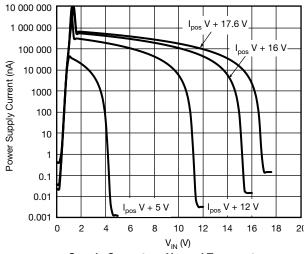


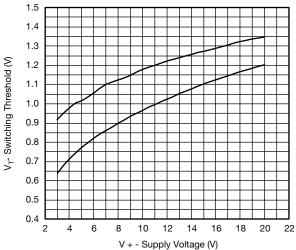


## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

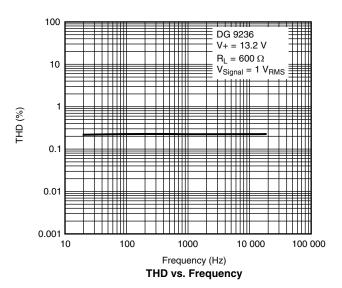


# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

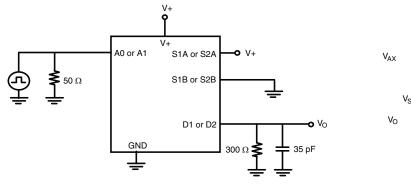




Supply Current vs.  $V_{\mbox{\scriptsize IN}}$  and Temperature Switching Threshold (Lower) vs. Single Supply Voltage



## **TEST CIRCUITS**



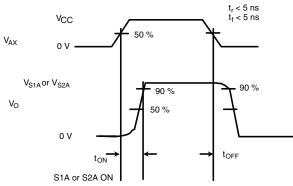


Figure 1. Enable Switching Time

### **TEST CIRCUITS**

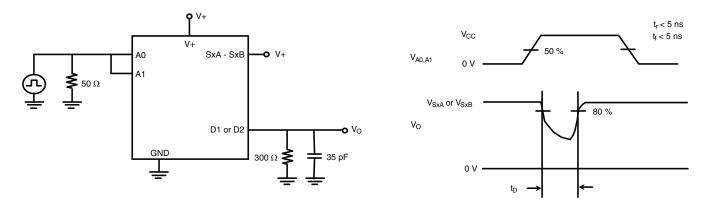


Figure 2. Break-Before-Make

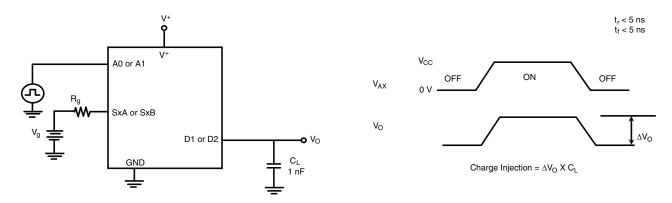


Figure 3. Charge Injection

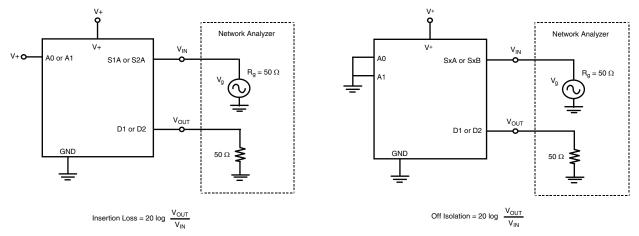


Figure 4. Insertion Loss

Figure 5. Off-Isolation

## **TEST CIRCUITS**

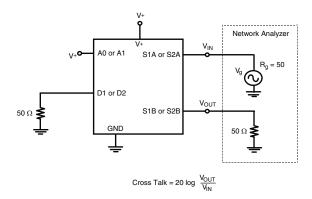


Figure 6. Crosstalk

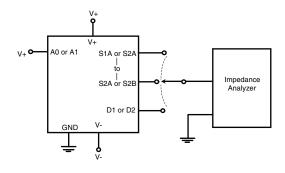
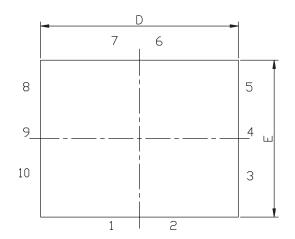
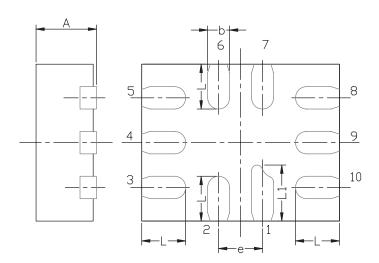


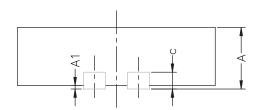
Figure 7. Source/Drain Capacitance

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?67049.

## **MINI QFN-10L CASE OUTLINE**







DIM	M	IILLIMETER	IS .	INCHES			
DIIVI	MIN.	NAM.	MAX.	MIN.	NAM.	MAX.	
Α	0.50	0.55	0.60	0.0197	0.0217	0.0236	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.15	0.20	0.25	0.006	0.008	0.010	
С	0.15 REF			0.006 REF			
D	1.75	1.80	1.85	0.069	0.071	0.073	
Е	1.35	1.40	1.45	0.053	0.055	0.057	
е		0.40 BSC		0.016 BSC			
L	0.35	0.40	0.45	0.014	0.016	0.018	
L1	0.45	0.50	0.55	0.0177	0.0197	0.0217	

ECN T-07039-Rev. A, 12-Feb-07

DWG: 5957





Vishay

# **Disclaimer**

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